25K809, 25K809A

Silicon N-channel Power F-MOS FET

■ Features

- Low ON resistance R_{DS} (on) : R_{DS} (on) = 1.5 Ω (typ.)
- High switching rate : $t_f = 85$ ns (typ.)
- No secondary breakdown
- High breakdown voltage, large power

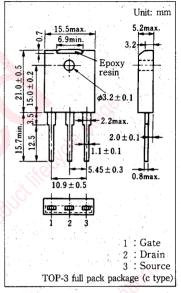
■ Application

- No contact relay
- Solenoid drive
- Motor drive
- Control equipment
- Switching power source

■ Absolute Maximum Ratings (Tc=25°C)

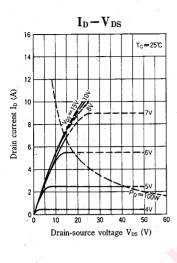
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Item	Symbol	Value	Unit		
Drain-source voltage	2SK809.	N7	800	17	
	2SK809A	V_{DSS}	900	· ' · .	
Gate-source voltage	V _{GSS}	±20	V		
Drain current	DC	I_D	5		
	Peak-to-peak value		10	NOA.	
Power dissipation	Tc=25℃	D	100	W	
	Ta=25℃	P_{D}	3.0		
Channel temperature		Tch	150	°C (
Storage temperature		T _{stg}	-55~+150	°C .	

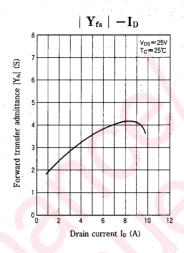
■ Package Dimensions

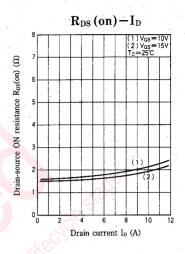


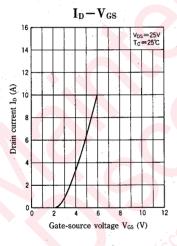
■ Electrical Characteristics (Tc=25°C)

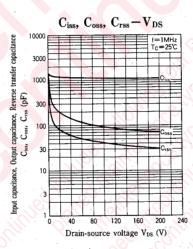
Item	Symbol	Condition	min.	typ.	max.	Unit
Drain current	I_{DSS}	$V_{DS} = 640 V, V_{GS} = 0$	-90.		0.1	mA
Gate-source current	I_{GSS}	$V_{GS} = \pm 20 V, V_{DS} = 0$	10		±1	μA
Drain-source voltage 2SK809 2SK809A	V _{DSS}	$I_D = 1 \text{ mA}, V_{GS} = 0$	800			W
			900			٧
Gate threshold voltage	V _{th}	$V_{DS}=25V$, $I_D=1mA$	1		. 5	. V .
Drain-source ON resistance	R _{DS} (on)	$V_{GS} = 10V, I_D = 3A$		1.5	3.0	Ω
Forward transfer admittance	Yfs	$V_{DS} = 25V, I_D = 3A$	1.5	2.8		S
Input capacitance	Ciss	V _{DS} =20V, V _{GS} =0, f=1MHz		1270		pF
Output capacitance	Coss			220		pF
Reverse transfer capacitance	C _{rss}		1	80		pF
Turn-on time	ton	$V_{GS} = 10V, I_D = 3A$ $V_{DD} = 200V, R_L = 66 \Omega$		60	1 1	ns
Fall time	t _f			85		ns
Delay time	t d (off)			280		ns

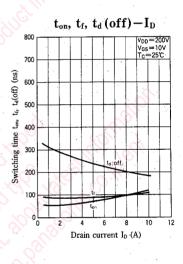


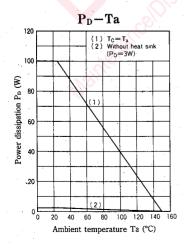


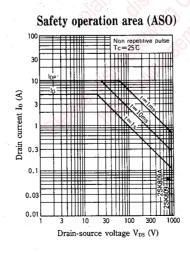


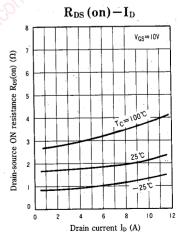












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